### Res. Asst. GÖKSENİN HANDE BAYAZIT

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#### **International Researcher IDs**

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#### **Education Information**

Postgraduate, Middle East Technical University, Graduate School of Natural and Applied Sciences, Turkey 2018 - 2020 Undergraduate, Middle East Technical University, Faculty of Engineering, Turkey 2014 - 2018

#### **Research Areas**

Electrical Machine Theory and Design, Electric Motor Drivers, Power Converters

### **Academic Titles / Tasks**

Research Assistant, Middle East Technical University, Faculty of Engineering, Department of Electrical and Electronics Engineering, 2019 - Continues

# Refereed Congress / Symposium Publications in Proceedings

- I. A simulink model for the induction machine with an inter-turn short circuit fault ŞAHİN İ., BAYAZIT G. H., KEYSAN O.
  - 2020 International Conference on Electrical Machines, ICEM 2020, Virtual, Gothenburg, Sweden, 23 26 August 2020, pp.1273-1279
- II. Fault Tolerance Capabilities of Three, Four and Six-Phase Configurations of a 24 Slot Modular PMSM

Bayazit G. H., Uğur M., KEYSAN O.

IEEE International Conference on Power Electronics and Drive Systems (PEDS), Toulouse, France, 9 - 12 July 2019

- III. METU Smart Campus Project (iEAST)
  - ERTEKİN BOLELLİ Ş., KEYSAN O., GÖL M., beyazıt h., YILDIZ T., Marr A., Ganji M., Teimourzadeh S., Tör O. B., Özkavaf S.
  - International Conference on New Technologies, Development and Application, Sarajevo, Bosnia And Herzegovina, 27 29 June 2019, vol.76, pp.287-297
- IV. Fault Tolerance Capabilities of Three, Four and Six-Phase Configurations of a 24 Slot Modular PMSM BAYAZIT G. H., Ugur M., KEYSAN O.
  - 13th IEEE International Conference on Power Electronics and Drive Systems, PEDS 2019, Toulouse, France, 9 12 July 2019

## Metrics

Publication: 4

Citation (WoS): 2

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